

<b>Notice of References Cited</b>	Application/Control No. 09/980,487	Applicant(s)/Patent Under Reexamination MUELLER, HORST	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,606,317	02-1997	Cloonan et al.	341/58
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
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2663

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,584,118 B1	06-2003	Russell et al	370/466
	B	US-5,706,285	01-1998	Saijonmaa et al	370/395
	C	US-6,014,708	01-2000	Klish	709/232
	D	US-6,222,848 B1	04-2001	Hayward et al	370/412
	E	US- <del>6</del> ,5247,518	09-1993	Takiyasu et al	370/85.15
	F	US-6,151,336	11-2000	Cheng et al	370/535
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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